

## Single N-Channel MOSFET

### DESCRIPTION

SMC6242 uses trench technology. This advanced technology has been especially tailored to minimize on-state resistance, provide superior, fast switching performance, and withstand high energy pulse in the avalanche and commutation mode.

### PART NUMBER INFORMATION

**SMC 6242 H - TR G**  
 a    b    c    d    e

- a : Company name.
- b : Product Serial number.
- c : Package code            NA:DFN3.3X3.3A-8
- d : Handling code            TR:Tape&Reel
- e : Green produce code    G:RoHS Compliant

### FEATURES

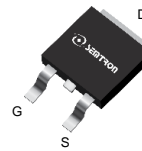
**$V_{DS} = 60V$ ,  $I_D = 23.5A$**

$R_{DS(ON)} = 32m\Omega(Typ.)@V_{GS} = 10V$   
 $R_{DS(ON)} = 38m\Omega(Typ.)@V_{GS} = 4.5V$

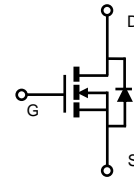
- ◆ 100% EAS and Guaranteed

### APPLICATIONS

- ◆ DC/DC Power System
- ◆ Motor Drive
- ◆ Load Switch



TO-252



### ABSOLUTE MAXIMUM RATINGS ( $T_A = 25^\circ C$ Unless otherwise noted)

Symbol	Parameter	Rating	Units
$V_{DS}$	Drain-Source Voltage	60	V
$V_{GS}$	Gate-Source Voltage	$\pm 20$	V
$I_D$	Continuous Drain Current	$T_C = 25^\circ C$	23.5
		$T_C = 100^\circ C$	14.9
$I_{DM}$	Pulsed Drain Current <sup>A</sup>	94	A
$I_D$	Continuous Drain Current	$T_A = 25^\circ C$	9
		$T_A = 70^\circ C$	7.3
$P_D$	Power Dissipation <sup>B</sup>	$T_A = 25^\circ C$	6.3
		$T_A = 70^\circ C$	4
$I_{AS}$	Avalanche Current <sup>A</sup>	20	A
EAS	Single Pulse Avalanche energy $L=0.1mH$ <sup>AF</sup>	20	mJ
$P_D$	Power Dissipation <sup>C</sup>	$T_C = 25^\circ C$	41.7
		$T_C = 100^\circ C$	16.7
$T_J$	Operation Junction Temperature	-55/150	$^\circ C$
$T_{STG}$	Storage Temperature Range	-55/150	$^\circ C$

### THERMAL RESISTANCE

Symbol	Parameter	Typ	Max	Units
$R_{\theta JA}$	Thermal Resistance Junction to Ambient <sup>B</sup>	$t \leq 10s$	20	$^\circ C/W$
	Thermal Resistance Junction to Ambient <sup>BD</sup>	Steady-State	50	
$R_{\theta JC}$	Thermal Resistance Junction to Case		3	

## ELECTRICAL CHARACTERISTICS ( $T_A = 25^\circ\text{C}$ Unless otherwise noted)

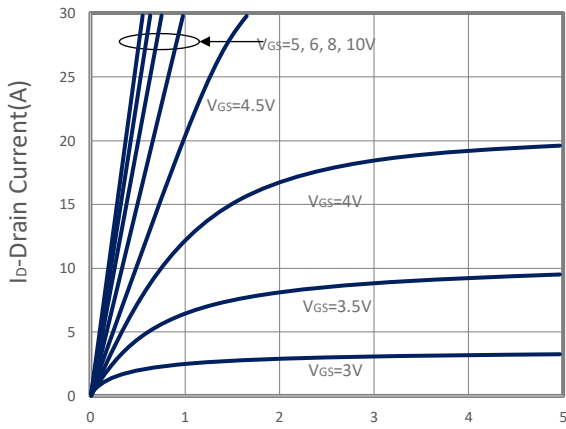
Symbol	Parameter	Condition	Min	Typ	Max	Unit
<b>Static Parameters</b>						
BV <sub>DSS</sub>	Drain-Source Breakdown Voltage	V <sub>GS</sub> =0V, I <sub>D</sub> =250 $\mu$ A	60			V
V <sub>GS(th)</sub>	Gate Threshold Voltage	V <sub>DS</sub> =V <sub>GS</sub> , I <sub>D</sub> =250 $\mu$ A	1	1.5	2.5	V
I <sub>GSS</sub>	Gate Leakage Current	V <sub>DS</sub> =0V, V <sub>GS</sub> = $\pm$ 20V			$\pm$ 100	nA
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	V <sub>DS</sub> =60V, V <sub>GS</sub> =0V, T <sub>J</sub> =25 $^\circ$ C			1	$\mu$ A
		V <sub>DS</sub> =48V, V <sub>GS</sub> =0V, T <sub>J</sub> =75 $^\circ$ C			10	
R <sub>DS(ON)</sub>	Drain-source On-Resistance <sup>E</sup>	V <sub>GS</sub> =10V, I <sub>D</sub> =9A V <sub>GS</sub> =4.5V, I <sub>D</sub> =6A		32 38	38 48	m $\Omega$
G <sub>fs</sub>	Forward Transconductance	V <sub>DS</sub> =5V, I <sub>D</sub> =9A		15.2		S
<b>Diode Characteristics</b>						
V <sub>SD</sub>	Diode Forward Voltage <sup>E</sup>	I <sub>S</sub> =1A, V <sub>GS</sub> =0V		0.7	1	V
I <sub>S</sub>	Continuous Source Current				11.8	A
t <sub>rr</sub>	Reverse Recovery Time	I <sub>S</sub> =9A, dI/dt=100A/ $\mu$ s		17		ns
Q <sub>rr</sub>	Reverse Recovery Charge			21		nC
<b>Dynamic and Switching Parameters</b>						
Q <sub>g</sub>	Total Gate Charge	V <sub>DS</sub> =30V, V <sub>GS</sub> =10V, I <sub>D</sub> =9A		18	25.3	nC
Q <sub>g</sub>	Total Gate Charge (4.5V)			8.8	11.9	
Q <sub>gs</sub>	Gate-Source Charge			2.5	3.4	
Q <sub>gd</sub>	Gate-Drain Charge			4.2	5.7	
C <sub>iss</sub>	Input Capacitance	V <sub>DS</sub> =30V, V <sub>GS</sub> =0V, f=1MHz		1020		pF
C <sub>oss</sub>	Output Capacitance			78		
C <sub>rss</sub>	Reverse Transfer Capacitance			45		
R <sub>g</sub>	Gate Resistance	V <sub>GS</sub> =0V, V <sub>DS</sub> =0V, F=1MHz		2.5		$\Omega$
t <sub>d(on)</sub>	Turn-On Time <sup>E</sup>	V <sub>DD</sub> =30V, V <sub>GS</sub> =10V R <sub>G</sub> =3.3 $\Omega$ , I <sub>D</sub> =1A		4.8	9	nS
t <sub>r</sub>				16.6	32	
t <sub>d(off)</sub>	Turn-Off Time <sup>E</sup>			23	44	
T <sub>f</sub>				5.4	10	

Note: Absolute maximum ratings are those values beyond which the device could be permanently damaged.

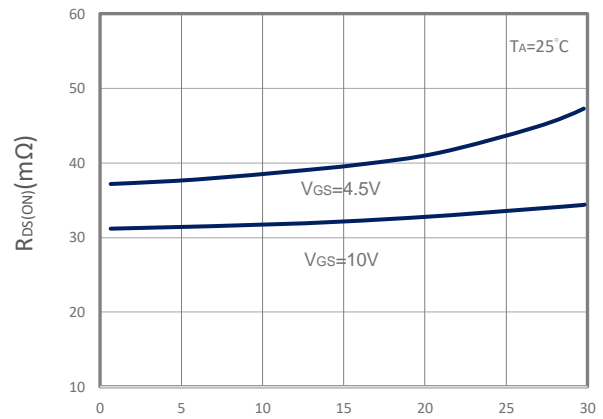
- A. Pulsed width limited by maximum junction temperature, T<sub>J(MAX)</sub>=150 $^\circ$ C.
- B. The value of R<sub>θJA</sub> is measured with the device mounted on 1in2 FR-4 board in a still air environment with maximum junction temperature T<sub>J(MAX)</sub>=150 $^\circ$ C (initial temperature T<sub>A</sub>=25 $^\circ$ C).
- C. T<sub>J(MAX)</sub>=150 $^\circ$ C, using junction-to-ambient thermal resistance, t ≤ 10sec.
- D. T<sub>J(MAX)</sub>=150 $^\circ$ C, using junction-to-case thermal resistance (R<sub>θJC</sub>) is more useful in additional heat sinking is used.
- E. The data tested by pulsed, pulse width ≤ 300 $\mu$ s, duty cycle ≤ 2%.
- F. The EAS data shows Max, tested and pulse width limited by T<sub>J(MAX)</sub>=150 $^\circ$ C (initial temperature T<sub>J</sub>=25 $^\circ$ C).

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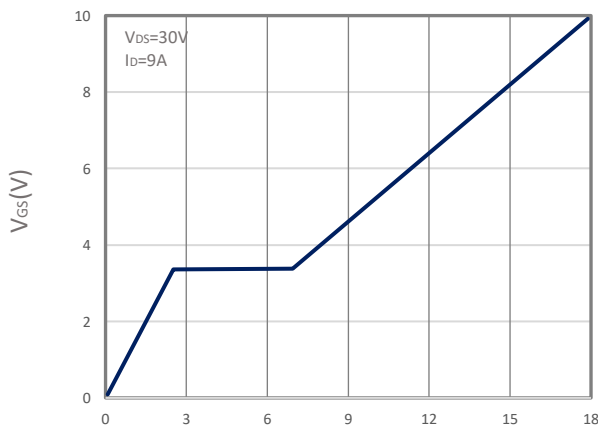
## TYPICAL CHARACTERISTICS



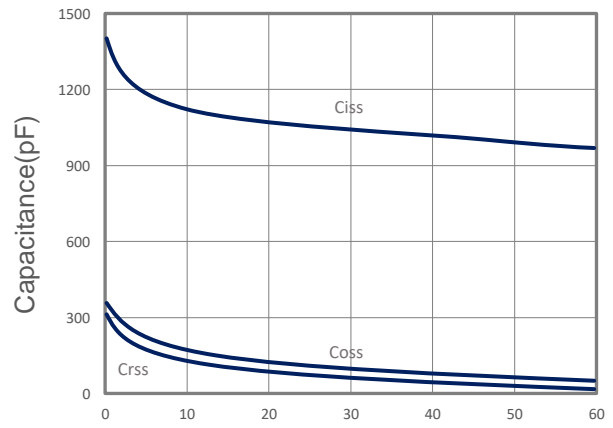
Vds-Drain Source Voltage (V)  
**Output Characteristics**



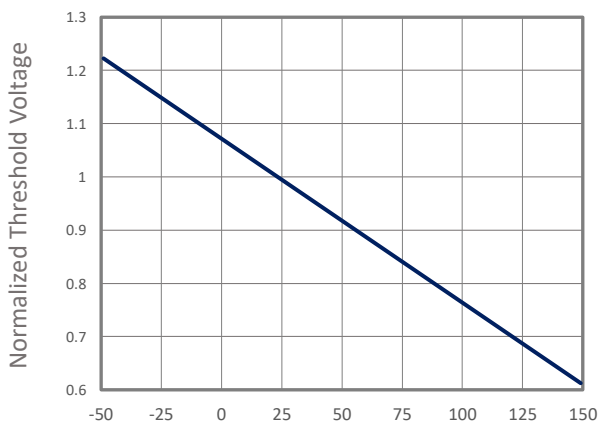
Id-Drain Current (A)  
**Drain-Source On Resistance**



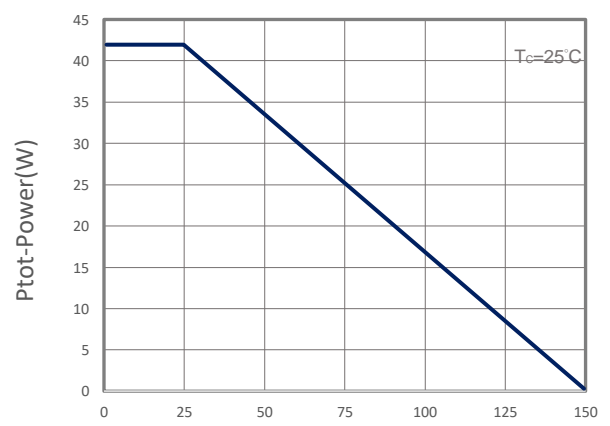
Qg-Gate Charge (nC)  
**Gate Charge**



Vds-Drain Source Voltage (V)  
**Capacitance**

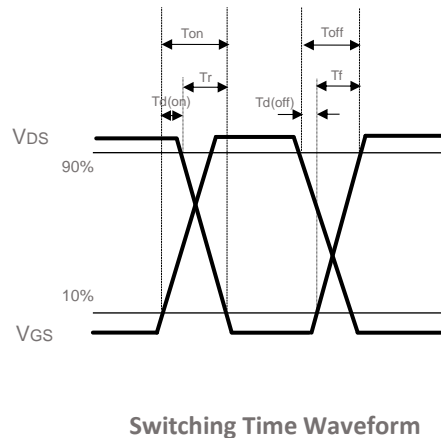
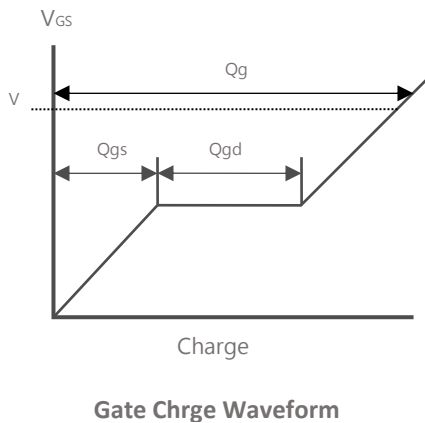
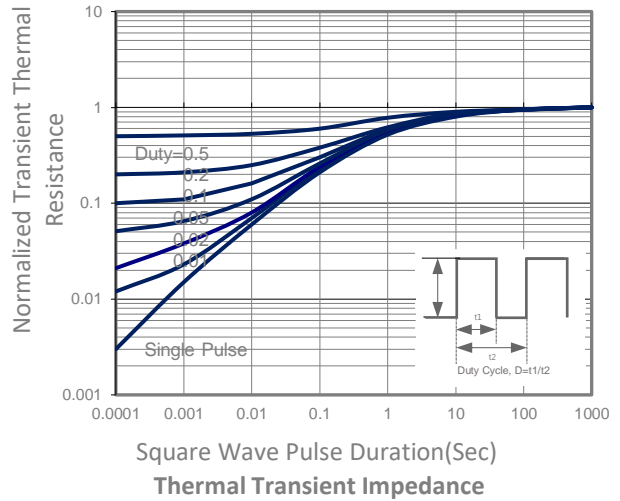
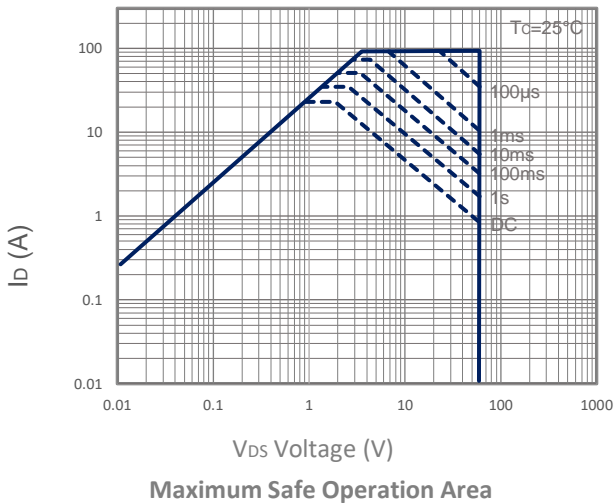
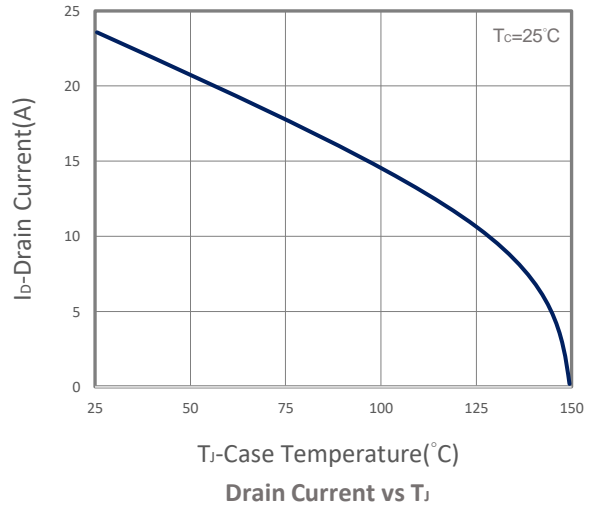
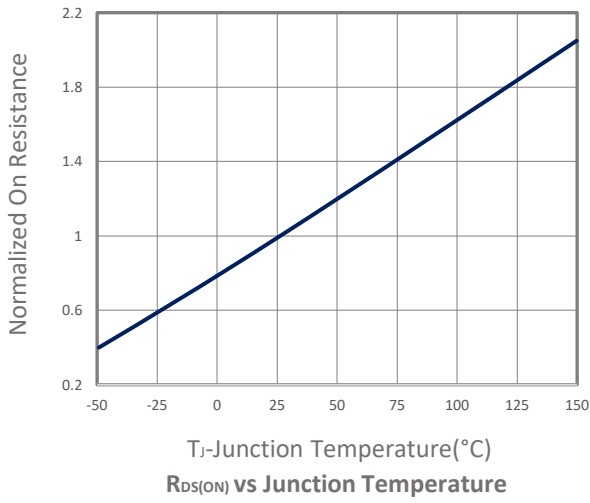


Tj-Junction Temperature (°C)  
**Gate Threshold Voltage**

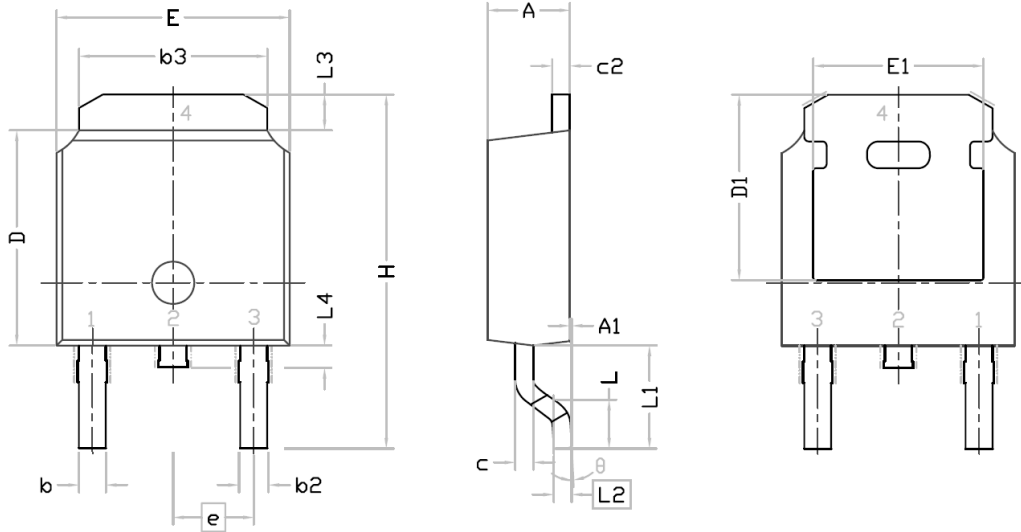


Tj-Junction Temperature (°C)  
**Power Dissipation**

## TYPICAL CHARACTERISTICS



## TO-252 PACKAGE DIMENSIONS



Symbol	Dimensions In Millimeters		Dimensions In Inches	
	Min.	Max.	Min.	Max.
A	2.200	2.380	0.087	0.094
A1	0.000	0.127	0.000	0.005
b	0.640	0.880	0.025	0.035
b2	0.770	1.140	0.030	0.045
b3	5.210	5.460	0.205	0.215
c	0.460	0.600	0.018	0.024
c2	0.460	0.580	0.018	0.023
D	6.000	6.223	0.236	0.245
D1	5.210	-	0.205	-
E	6.400	6.731	0.252	0.265
E1	4.400	-	0.173	-
e	2.286 BSC.		0.090 BSC.	
H	9.400	10.40	0.370	0.409
L	1.400	1.770	0.055	0.070
L1	2.743 REF.		0.108 REF.	
L2	0.508 BSC.		0.020 BSC.	
L3	0.890	1.270	0.035	0.050
L4	0.640	1.010	0.025	0.040
θ	0°	10°	0°	10°

Recommended Land Pattern

